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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/522,461	JEONG ET AL.	
Examiner	Art Unit	
Edna Wong	1753	

SEARCHED				
Class	Subclass	Date	Examiner	
204	157.2	7/19/2006	EW	
		1		
				

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
157.2	8/20/2007	EW		
	Subclass	Subclass Date		

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
Inventor Search	7/19/2006	EW		
EAST	7/19/2006	EW		
STN	7/19/2006	EW		
Search Updated	3/10/2007	EW		
Interference Search	8/20/2007	EW		